

Search Notes



Application/Control No.

10/755,445

Examiner

CHUONG T. HO

Applicant(s)/Patent under Reexamination

AHOOR ET AL.

Art Unit

2664

SEARCHED

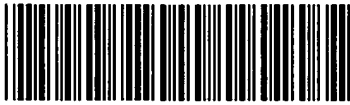
Class	Subclass	Date	Examiner
709	224 ✓	08/10/05	CH
709	227		
714	712 ✓		
714	31 ✓		
707	10		
370	230 ✓		
370	241 ✓		
709	223 ✓		
714	38 ✓		
714	46 ✓		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
WEST (TEXT SEARCH)	08/10/05	CH
WEST (CLASS SEARCH)		
EAST		
STN		
IEEE	08/10/05	CH
Consulting with primary Examiner Dinh Dung	08/19/05	CH
709/200 ✓		

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(INCLUDING SEARCH STRATEGY)**

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